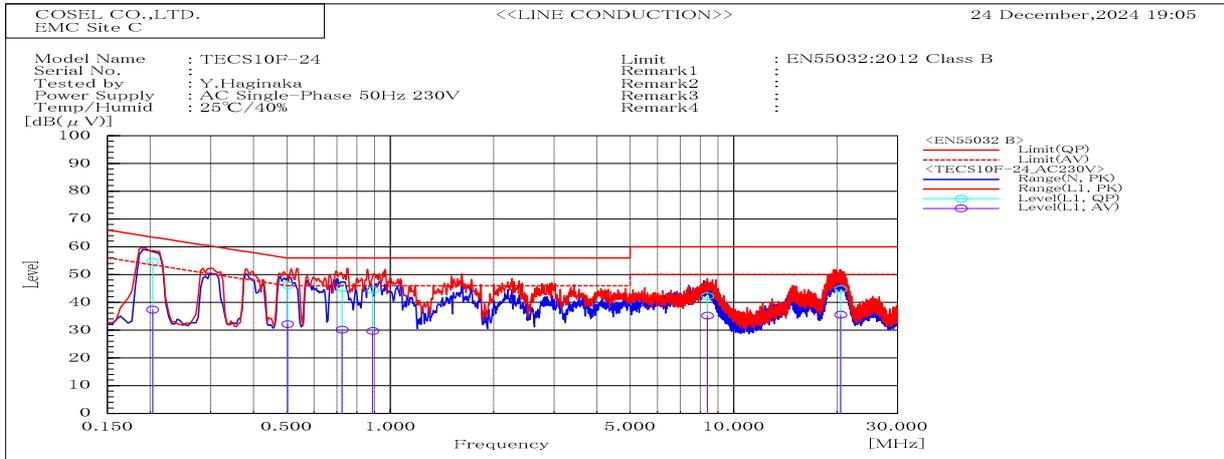
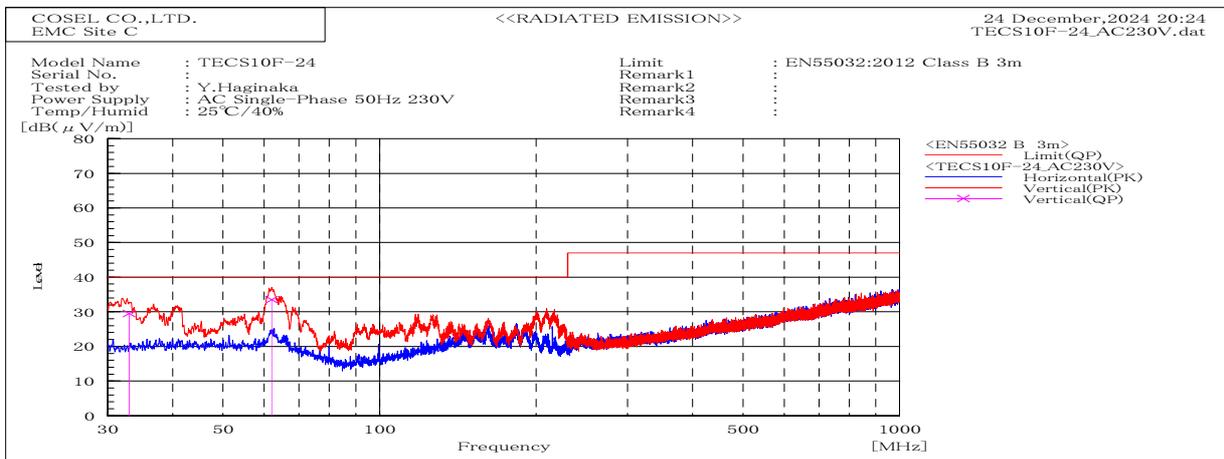


DATA SHEET		Date	24-Mar-25
Model	TECS10F-24	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma



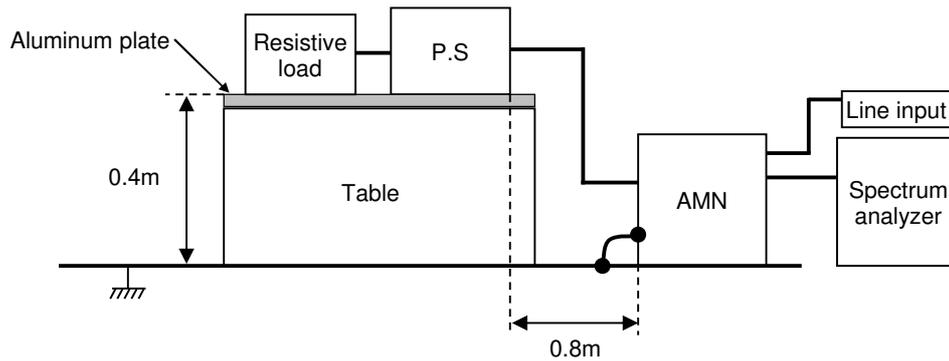
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.203	L1	54.7	37.4	63.5	53.5	8.8	16.1	Pass	
0.502	L1	46.1	32.1	56	46	9.9	13.9	Pass	
0.724	L1	45.3	30.1	56	46	10.7	15.9	Pass	
0.889	L1	44.4	29.7	56	46	11.6	16.3	Pass	
8.389	L1	42.2	35.2	60	50	17.8	14.8	Pass	
20.497	L1	44.8	35.5	60	50	15.2	14.5	Pass	



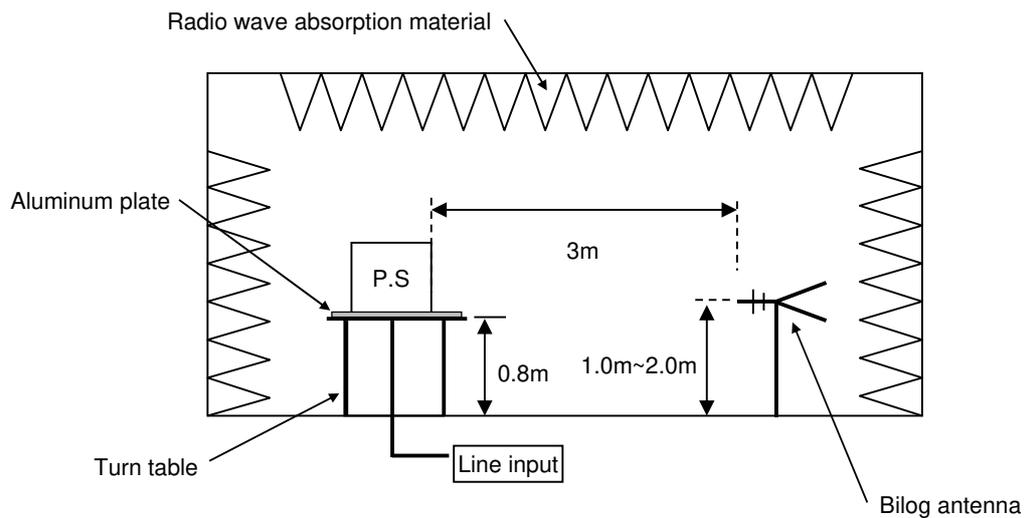
Frequency MHz	Polarization	Stability	Level dB(μV/m)		Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV						
33.006	V	Stable	29.5	40	40	10.5	Pass	100	223.5	
62.027	V	Stable	33.5	40	40	6.5	Pass	100	169.9	

DATA SHEET		Date	24-Mar-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

1. Line conduction



2. Radiated emission



Conditions

Test : EMI
Model Name : TECS10F-24

1.LINE CONDUCTION**2.RADIATED EMISSION**